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SCPS069F-JULY 2001-REVISED NOVEMBER 2015

# PCF8574A Remote 8-Bit I/O Expander for I<sup>2</sup>C Bus

Technical

Documents

### 1 Features

- Low Standby-Current Consumption of 10 µA Max
- I<sup>2</sup>C to Parallel-Port Expander
- Open-Drain Interrupt Output
- Compatible With Most Microcontrollers
- Latched Outputs With High-Current Drive Capability for Directly Driving LEDs
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II

# 2 Applications

- Telecom Shelters: Filter Units
- Servers
- Routers (Telecom Switching Equipment)
- Personal Computers
- Personal Electronics
- Industrial Automation
- Products with GPIO-Limited Processors

# 3 Description

Tools &

Software

This 8-bit input/output (I/O) expander for the two-line bidirectional bus (I<sup>2</sup>C) is designed for 2.5-V to 6-V  $V_{CC}$  operation.

Support &

Community

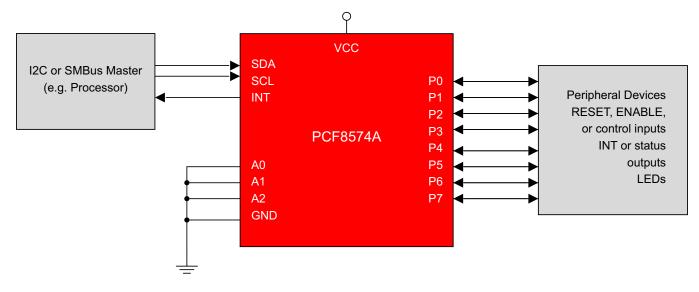
The PCF8574A device provides general-purpose remote I/O expansion for most microcontroller families via the  $I^2C$  interface [serial clock (SCL), serial data (SDA)].

The device features an 8-bit quasi-bidirectional I/O port (P0–P7), including latched outputs with high-current drive capability for directly driving LEDs. Each quasi-bidirectional I/O can be used as an input or output without the use of a data-direction control signal. At power on, the I/Os are high. In this mode, only a current source to  $V_{CC}$  is active.

(4)

Device Information <sup>(1)</sup>							
PART NUMBER	PACKAGE (PIN)	BODY SIZE (NOM)					
	VQFN (20)	4.50 mm × 3.50 mm					
	PDIP (16)	19.30 mm × 6.35 mm					
PCF8574A	SOIC (16)	10.30 mm × 7.50 mm					
	TSSOP (20)	6.50 mm × 4.40 mm					
	TVSOP (20)	5.00 mm × 4.40 mm					

 For all available packages, see the orderable addendum at the end of the data sheet.



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#### Revision History 4

# Changes from Revision E (January 2015) to Revision F

#### Changes from Revision D (October 2005) to Revision E

Added Applications, Device Information table, Pin Functions table, ESD Ratings table, Thermal Information table,	
Typical Characteristics, Feature Description section, Device Functional Modes, Application and Implementation	
section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and	
Mechanical, Packaging, and Orderable Information section.	. 1
Deleted Ordering Information table.	1



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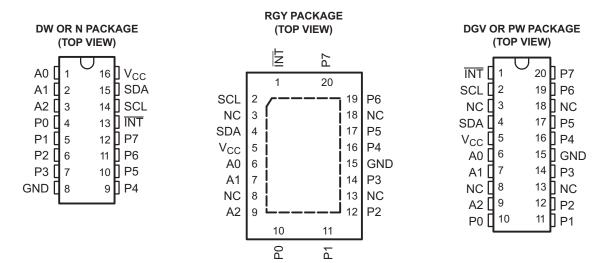
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# 5 Pin Configuration and Functions



#### **Pin Functions**

PIN				TYPE	DESCRIPTION
NAME	RGY	DGV or PW	DW or N	TIPE	DESCRIPTION
A[02]	6, 7, 9	6, 7, 9	1, 2, 3	Ι	Address inputs 0 through 2. Connect directly to $V_{\text{CC}}\xspace$ or ground. Pullup resistors are not needed.
GND	15	15	8		Ground
INT	1	1	13	0	Interrupt output. Connect to $V_{CC}$ through a pullup resistor.
NC	3, 8, 13, 18	3, 8, 13, 18	-		Do not connect
P[07]	10, 11, 12, 14, 16, 17, 19, 20	10, 11, 12, 14, 16, 17, 19, 20	4, 5, 6, 7, 9, 10, 11, 12	I/O	P-port input/output. Push-pull design structure.
SCL	2	2	14	I	Serial clock line. Connect to $V_{CC}$ through a pullup resistor
SDA	4	4	15	I/O	Serial data line. Connect to V <sub>CC</sub> through a pullup resistor.
V <sub>CC</sub>	5	5	16	_	Voltage supply

# 6 Specifications

# 6.1 Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	7	V
VI	Input voltage range <sup>(2)</sup>		-0.5	V <sub>CC</sub> + 0.5	V
Vo	Output voltage range <sup>(2)</sup>		-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0		-20	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-20	mA
I <sub>OK</sub>	Input/output clamp current	$V_{O}$ < 0 or $V_{O}$ > $V_{CC}$		±400	μA
I <sub>OL</sub>	Continuous output low current	$V_{O} = 0$ to $V_{CC}$		50	mA
I <sub>OH</sub>	Continuous output high current	$V_{O} = 0$ to $V_{CC}$		-4	mA
	Continuous current through $V_{CC}$ or GND			±100	mA
TJ	Junction temperature			150	°C
T <sub>stg</sub>	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

# 6.2 ESD Ratings

			VALUE	UNIT
N	Electrostatio discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	1000	V
V <sub>(ESD)</sub>		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins $^{\rm (2)}$	1500	v

JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
 JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

# 6.3 Recommended Operating Conditions

		MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage	2.5	6	V
VIH	High-level input voltage	$0.7 \times V_{CC}$	$V_{CC} + 0.5$	V
VIL	Low-level input voltage	-0.5	$0.3 \times V_{CC}$	V
I <sub>OH</sub>	High-level output current		-1	mA
I <sub>OL</sub>	Low-level output current		25	mA
T <sub>A</sub>	Operating free-air temperature	-40	85	°C

### 6.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		PCF8574A					
		DGV	DW	N	PW	RGY	UNIT
				16 PINS	20 PINS	20 PINS	
$\theta_{JA}$	Junction-to-ambient thermal resistance	92	57	67	83	37	°C/W

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report (SPRA953).

### 6.5 Electrical Characteristics

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over recommended (	operating free-a	Ir temperature rande	(unless otherwise noted)

	PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN	TYP <sup>(1)</sup>	MAX	UNIT	
VIK	Input diode clamp voltage	$I_{I} = -18 \text{ mA}$	2.5 V to 6 V	-1.2			V	
V <sub>POR</sub>	Power-on reset voltage <sup>(2)</sup>	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	6 V		1.3	2.4	V	
I <sub>OH</sub>	P port	V <sub>O</sub> = GND	2.5 V to 6 V	30		300	μA	
I <sub>OHT</sub>	P-port transient pullup current	High during acknowledge, V <sub>OH</sub> = GND	2.5 V		-1		mA	
	SDA	$V_0 = 0.4 V$	2.5 V to 6 V	3				
I <sub>OL</sub>	P port	V <sub>O</sub> = 1 V	5 V	10	25		mA	
	INT	$V_{O} = 0.4 V$	2.5 V to 6 V	1.6				
	SCL, SDA		2.5 V to 6 V			±5		
I <sub>I</sub>	INT	$V_{I} = V_{CC}$ or GND				±5	μA	
	A0, A1, A2	_				±5		
I <sub>IHL</sub>	P port	$V_1 \ge V_{CC} \text{ or } V_1 \le GND$	2.5 V to 6 V			±400	μA	
	Operating mode	$V_I = V_{CC}$ or GND, $I_O = 0$ , $f_{SCL} = 100 \text{ kHz}$	<u> </u>		40	100		
I <sub>CC</sub>	Standby mode	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	6 V		2.5	10	μA	
Ci	SCL	$V_{I} = V_{CC}$ or GND	2.5 V to 6 V		1.5	7	pF	
~	SDA				3	7	_	
C <sub>io</sub>	P port	$V_{IO} = V_{CC}$ or GND	2.5 V to 6 V		4	10	pF	

(1) All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ . (2) The power-on reset circuit resets the I<sup>2</sup>C-bus logic with  $V_{CC} < V_{POR}$  and sets all I/Os to logic high (with current source to  $V_{CC}$ ).

# 6.6 I<sup>2</sup>C Interface Timing Requirements

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 12)

			MIN	MAX	UNIT
f <sub>scl</sub>	I <sup>2</sup> C clock frequency			100	kHz
t <sub>sch</sub>	I <sup>2</sup> C clock high time		4		μs
t <sub>scl</sub>	I <sup>2</sup> C clock low time		4.7		μs
t <sub>sp</sub>	I <sup>2</sup> C spike time			100	ns
t <sub>sds</sub>	I <sup>2</sup> C serial-data setup time		250		ns
t <sub>sdh</sub>	I <sup>2</sup> C serial-data hold time		0		ns
t <sub>icr</sub>	I <sup>2</sup> C input rise time			1	μs
t <sub>icf</sub>	I <sup>2</sup> C input fall time			0.3	μs
t <sub>ocf</sub>	I <sup>2</sup> C output fall time (10-pF to 400-pF bus)			300	ns
t <sub>buf</sub>	I <sup>2</sup> C bus free time between stop and start		4.7		μs
t <sub>sts</sub>	I <sup>2</sup> C start or repeated start condition setup		4.7		μs
t <sub>sth</sub>	I <sup>2</sup> C start or repeated start condition hold		4		μs
t <sub>sps</sub>	I <sup>2</sup> C stop-condition setup		4		μs
t <sub>vd</sub>	Valid-data time	SCL low to SDA output valid		3.4	μs
Cb	I <sup>2</sup> C bus capacitive load			400	pF

# 6.7 Switching Characteristics

over recommended operating free-air temperature range,  $C_L \le 100 \text{ pF}$  (unless otherwise noted) (see Figure 13)

	PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	МАХ	UNIT
t <sub>pv</sub>	, Output data valid	SCL	P port		4	μs
t <sub>su</sub>	Input data setup time	P port	SCL	0		μs
t <sub>h</sub>	Input data hold time	P port	SCL	4		μs
t <sub>iv</sub>	Interrupt valid time	P port	ĪNT		4	μs
t <sub>ir</sub>	Interrupt reset delay time	SCL	INT		4	μs

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PCF8574A

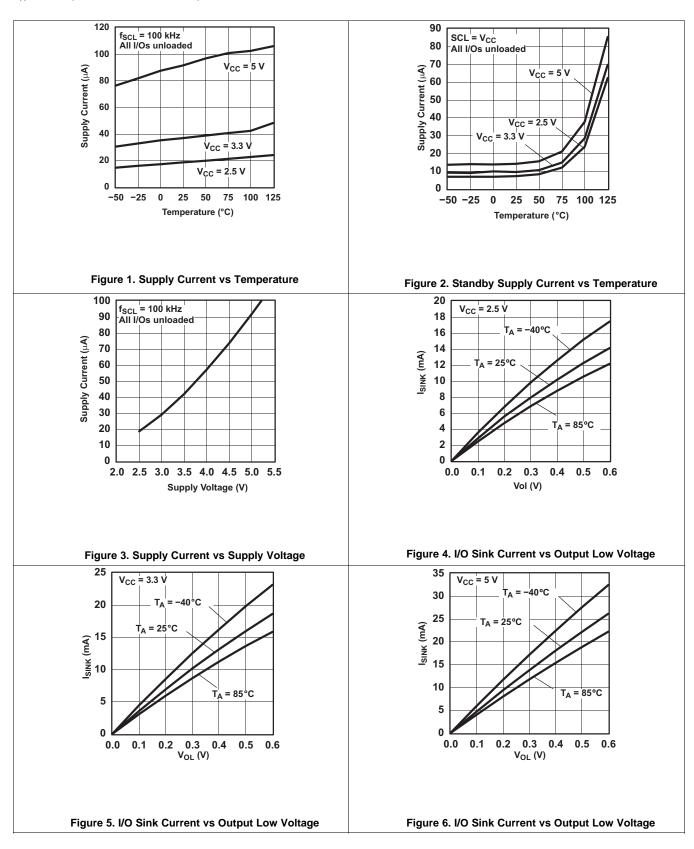
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### 6.8 Typical Characteristics

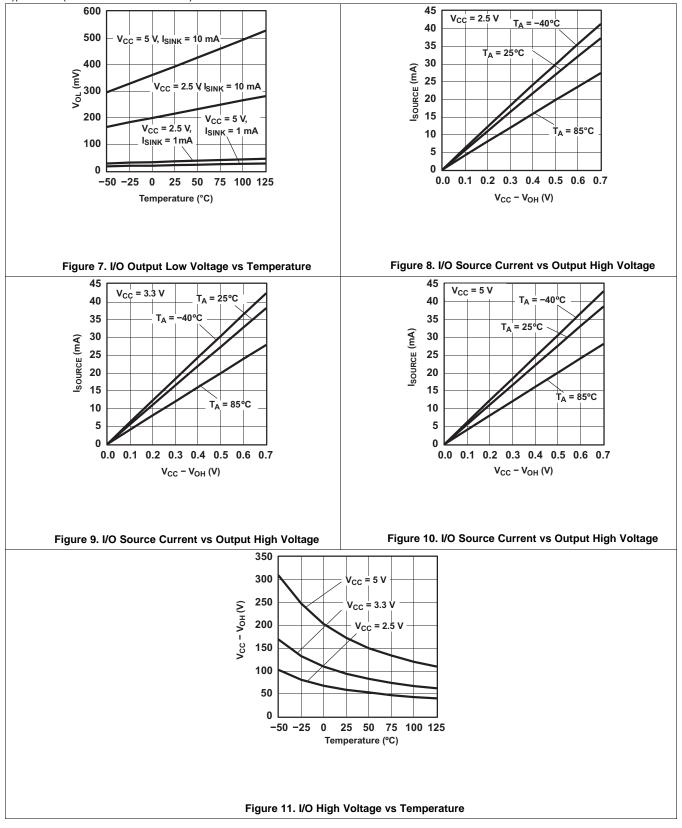
 $T_A = 25^{\circ}C$  (unless otherwise noted)





### **Typical Characteristics (continued)**

 $T_A = 25^{\circ}C$  (unless otherwise noted)



**ISTRUMENTS** 

EXAS

# 7 Parameter Measurement Information

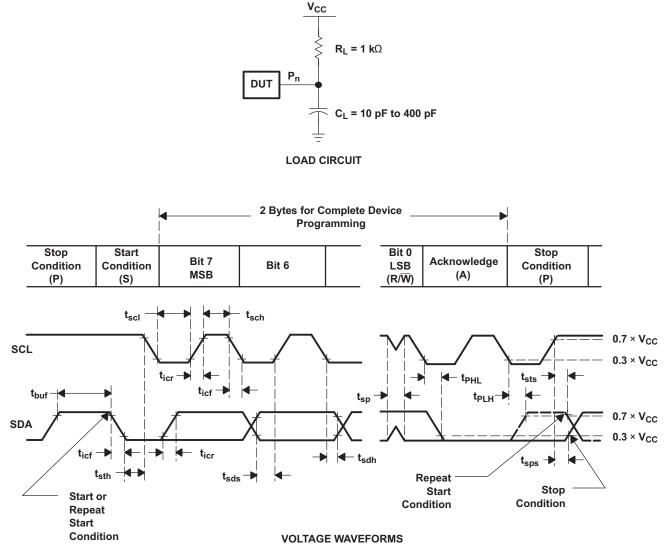
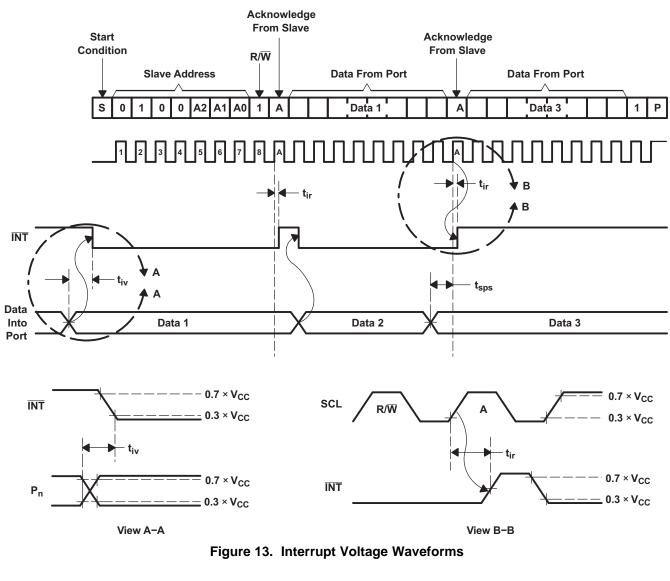


Figure 12. I<sup>2</sup>C Interface Load Circuit and Voltage Waveforms







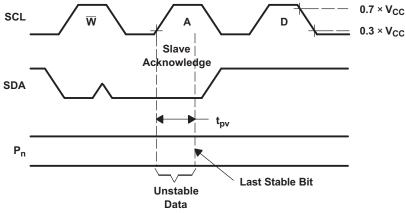


Figure 14. I<sup>2</sup>C Write Voltage Waveforms

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# Parameter Measurement Information (continued)

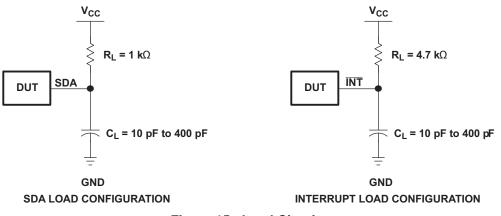


Figure 15. Load Circuits



# 8 Detailed Description

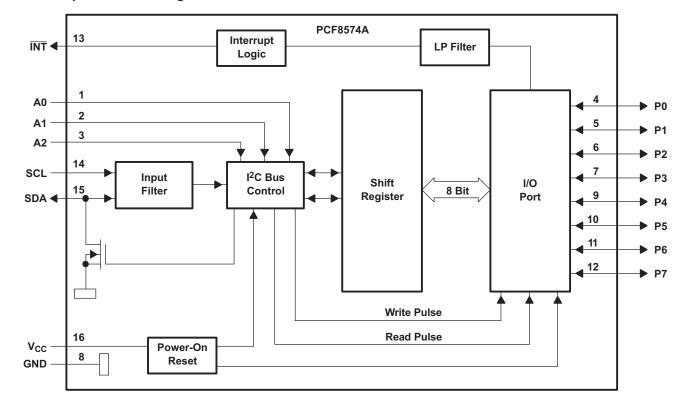
The PCF8574A device provides general-purpose remote I/O expansion for most microcontroller families via the I<sup>2</sup>C interface [serial clock (SCL), serial data (SDA)].

The device features an 8-bit quasi-bidirectional I/O port (P0–P7), including latched outputs with high-current drive capability for directly driving LEDs. Each quasi-bidirectional I/O can be used as an input or output without the use of a data-direction control signal. At power on, the I/Os are high. In this mode, only a current source to  $V_{CC}$  is active. An additional strong pullup to  $V_{CC}$  allows fast rising edges into heavily loaded outputs. This device turns on when an output is written high and is switched off by the negative edge of SCL. The I/Os should be high before being used as inputs.

The PCF8574A device provides an open-drain output ( $\overline{INT}$ ) that can be connected to the interrupt input of a microcontroller. An interrupt is generated by any rising or falling edge of the port inputs in the input mode. After time, t<sub>iv</sub>,  $\overline{INT}$  is valid. Resetting and reactivating the interrupt circuit is achieved when data on the port is changed to the original setting or data is read from, or written to, the port that generated the interrupt. Resetting occurs in the read mode at the acknowledge bit after the rising edge of the SCL signal, or in the write mode at the acknowledge bit after the SCL signal. Interrupts that occur during the acknowledge clock pulse can be lost (or be very short) due to the resetting of the interrupt during this <u>pulse</u>. Each change of the I/Os after resetting is detected and, after the next rising clock edge, is transmitted as INT. Reading from, or writing to, another device does not affect the interrupt circuit.

By sending an interrupt signal on this line, the remote I/O can inform the microcontroller if there is incoming data on its ports without having to communicate via the I<sup>2</sup>C bus. Therefore, the PCF8574A device can remain a simple slave device.

### 8.2 Functional Block Diagram



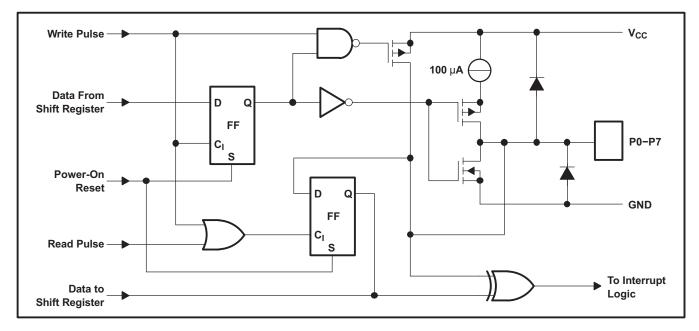
### 8.2.1 Simplified Block Diagram of Device

Pin numbers shown are for the DW and N packages.

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### **Functional Block Diagram (continued)**



# 8.2.2 Simplified Schematic Diagram of Each P-Port Input/Output

### 8.3 Feature Description

### 8.3.1 I<sup>2</sup>C Interface

I<sup>2</sup>C communication with this device is initiated by a master sending a start condition, a high-to-low transition on the SDA I/O while the SCL input is high. After the start condition, the device address byte is sent, most-significant bit (MSB) first, including the data direction bit (R/W). This device does not respond to the general call address. After receiving the valid address byte, this device responds with an acknowledge, a low on the SDA I/O during the high of the acknowledge-related clock pulse. The address inputs (A0–A2) of the slave device must not be changed between the start and the stop conditions.

The data byte follows the address acknowledge. If the  $R/\overline{W}$  bit is high, the data from this device are the values read from the P port. If the  $R/\overline{W}$  bit is low, the data are from the master, to be output to the P port. The data byte is followed by an acknowledge sent from this device. If other data bytes are sent from the master, following the acknowledge, they are ignored by this device. Data are output only if complete bytes are received and acknowledged. The output data will be valid at time,  $t_{pv}$ , after the low-to-high transition of SCL and during the clock cycle for the acknowledge.

A stop condition, a low-to-high transition on the SDA I/O while the SCL input is high, is sent by the master.

### 8.3.2 Interface Definition

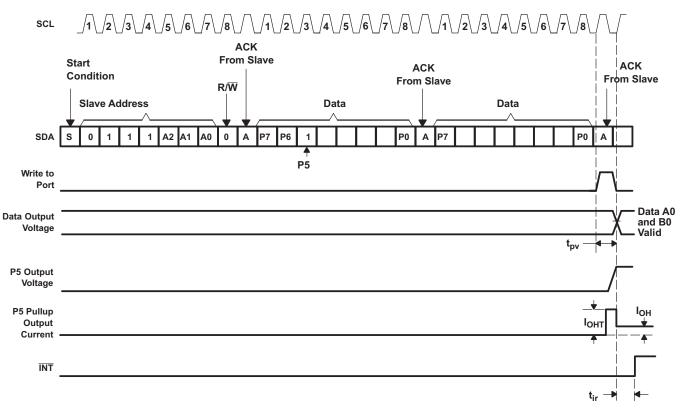
DVTE		BIT												
BYTE	7 (MSB)	6	5	4	3	2	1	0 (LSB)						
I <sup>2</sup> C slave address	L	Н	Н	Н	A2	A1	A0	R/W						
I/O data bus	P7	P6	P5	P4	P3	P2	P1	P0						

#### 8.3.3 Address Reference

I	NPUT	S	I <sup>2</sup> C BUS SLAVE 8-	
A2	A1	A0	I <sup>2</sup> C BUS SLAVE 8-BIT READ ADDRESS	BIT WRITE ADDRESS
L	L	L	113 (dec), 71 (hex)	112 (dec), 70 (hex)
L	L	н	115 (dec), 73 (hex)	114 (dec), 72 (hex)
L	Н	L	117 (dec), 75 (hex)	116 (dec), 74 (hex)
L	н	н	119 (dec), 77 (hex)	118 (dec), 76 (hex)
Н	L	L	121 (dec), 79 (hex)	120 (dec), 78 (hex)
Н	L	н	123 (dec), 7B (hex)	122 (dec), 7A (hex)
Н	Н	L	125 (dec), 7D (hex)	124 (dec), 7C (hex)
Н	Н	Н	127 (dec), 7F (hex)	126 (dec), 7E (hex)

## 8.4 Device Functional Modes

Figure 16 and Figure 17 show the address and timing diagrams for the write and read modes, respectively.



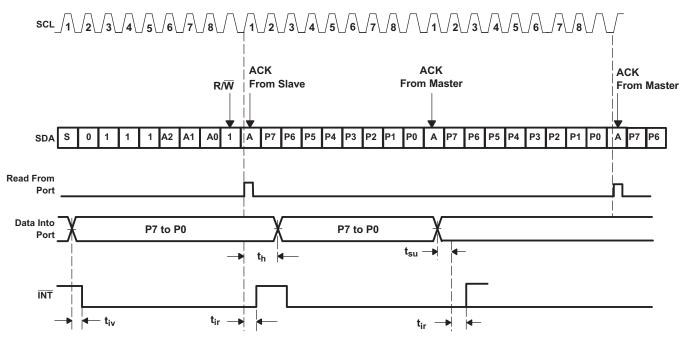




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# **Device Functional Modes (continued)**



A. A low-to-high transition of SDA while SCL is high is defined as the stop condition (P). The transfer of data can be stopped at any moment by a stop condition. When this occurs, data present at the latest ACK phase is valid (output mode). Input data is lost.





## 9 Application and Implementation

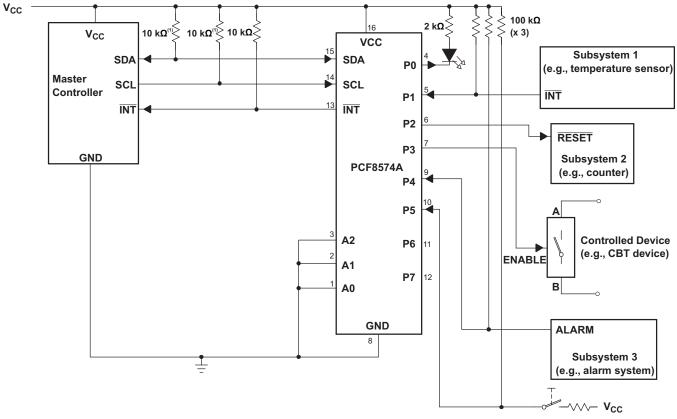
#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### 9.1 Application Information

Figure 18 shows an application in which the PCF8574A device can be used.

### 9.2 Typical Application



- (1) The SCL and SDA pins must be pulled up to  $V_{CC}$  because if SCL and SDA are pulled up to an auxiliary power supply that could be powered on while VCC is powered off, then the supply current, ICC, will increase as a result.
- A. Device address is configured as 0100000 for this example.
- B. P0, P2, and P3 are configured as outputs.
- C. P1, P4, and P5 are configured as inputs.
- D. P6 and P7 are not used and must be configured as outputs.

#### Figure 18. Application Schematic

Typical Application (continued)

9.2.1.1 Minimizing I<sub>CC</sub> When I/Os Control LEDs

9.2.1 Design Requirements

below V<sub>CC</sub>.

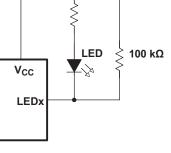
equal to V<sub>CC</sub> when the P-ports are configured as input to minimize current consumption. Figure 19 shows a highvalue resistor in parallel with the LED. Figure 20 shows V<sub>CC</sub> less than the LED supply voltage by at least V<sub>T</sub>. Both of these methods maintain the I/O V<sub>1</sub> at or above V<sub>CC</sub> and prevents additional supply current consumption when the P-port is configured as an input and the LED is off.

V<sub>CC</sub>

For battery-powered applications, it is essential that the voltage of P-ports controlling LEDs is greater than or

When the I/Os are used to control LEDs, normally they are connected to V<sub>CC</sub> through a resistor as shown in Figure 27. For a P-port configured as an input, I<sub>CC</sub> increases as V<sub>I</sub> becomes lower than V<sub>CC</sub>. The LED is a diode, with threshold voltage V<sub>T</sub>, and when a P-port is configured as an input the LED will be off but V<sub>I</sub> is a V<sub>T</sub> drop

Figure 19. High-Value Resistor in Parallel With LED



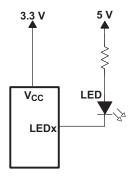


Figure 20. Device Supplied by a Lower Voltage





#### **Typical Application (continued)**

#### 9.2.2 Detailed Design Procedure

The pull-up resistors,  $R_P$ , for the SCL and SDA lines need to be selected appropriately and take into consideration the total capacitance of all slaves on the I<sup>2</sup>C bus. The minimum pull-up resistance is a function of V<sub>CC</sub>, V<sub>OL.(max)</sub>, and I<sub>OL</sub>:

$$\mathsf{R}_{\mathsf{p}(\mathsf{min})} = \frac{\mathsf{V}_{\mathsf{CC}} - \mathsf{V}_{\mathsf{OL}(\mathsf{max})}}{\mathsf{I}_{\mathsf{OL}}} \tag{1}$$

The maximum pull-up resistance is a function of the maximum rise time,  $t_r$  (300 ns for fast-mode operation,  $f_{SCL}$  = 400 kHz) and bus capacitance,  $C_b$ :

$$\mathsf{R}_{\mathsf{p}(\mathsf{max})} = \frac{t_{\mathsf{r}}}{0.8473 \times \mathsf{C}_{\mathsf{b}}} \tag{2}$$

The maximum bus capacitance for an  $I^2C$  bus must not exceed 400 pF for standard-mode or fast-mode operation. The bus capacitance can be approximated by adding the capacitance of the PCF8574A device,  $C_i$  for SCL or  $C_{io}$  for SDA, the capacitance of wires/connections/traces, and the capacitance of additional slaves on the bus.

#### 25 1.8 Standard-mode 1.6 Fast-mode 20 1.4 1.2 R<sub>p(max)</sub> (kOhm) R<sub>p(min)</sub> (kOhm) 15 1 0.8 10 0.6 04 5 0.2 $V_{CC} > 2V$ $V_{CC} \le 2$ 0 0 250 300 5 0 50 100 150 200 350 400 450 0.5 1 1.5 2 2.5 3 3.5 4 4.5 5.5 0 V<sub>CC</sub> (V) C<sub>b</sub> (pF) D008 Standard-mode $V_{OL} = 0.2^*V_{CC}$ , $I_{OL} = 2$ mA when $V_{CC} \le 2$ V Fast-mode (f<sub>SCL</sub>= 400 kHz, t<sub>r</sub>= 300 ns) $(f_{SCL} = 100 \text{ kHz}, t_r = 1 \mu \text{s})$ $V_{OL}$ = 0.4 V, $I_{OL}$ = 3 mA when $V_{CC}$ > 2 V Figure 21. Maximum Pull-Up Resistance (Rp(max)) Figure 22. Minimum Pull-Up Resistance (R<sub>p(min)</sub>) vs Bus Capacitance (C<sub>b</sub>) vs Pull-Up Reference Voltage (V<sub>CC</sub>)

#### 9.2.3 Application Curves

# 10 Power Supply Recommendations

# 10.1 Power-On Reset Requirements

In the event of a glitch or data corruption, PCF8574A can be reset to its default conditions by using the power-on reset feature. Power-on reset requires that the device go through a power cycle to be completely reset. This reset also happens when the device is powered on for the first time in an application.

The two types of power-on reset are shown in Figure 23 and Figure 24.

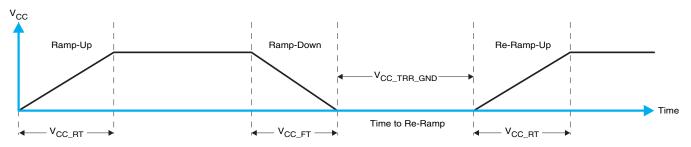


Figure 23. V<sub>CC</sub> is Lowered Below 0.2 V or 0 V and Then Ramped Up to V<sub>CC</sub>

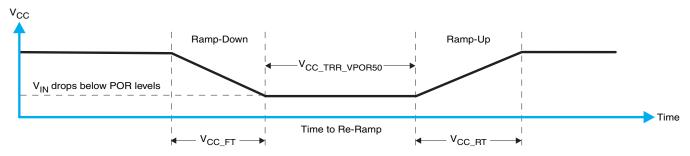


Figure 24.  $V_{CC}$  is Lowered Below the POR Threshold, Then Ramped Back Up to  $V_{CC}$ 

Table 1 specifies the performance of the power-on reset feature for PCF8574A for both types of power-on reset.

	PARAMETER	MIN	TYP	MAX	UNIT	
V <sub>CC_FT</sub>	Fall rate	See Figure 23	1		100	ms
V <sub>CC_RT</sub>	Rise rate	See Figure 23	0.01		100	ms
V <sub>CC_TRR_GND</sub>	Time to re-ramp (when V <sub>CC</sub> drops to GND)	See Figure 23	0.001			ms
V <sub>CC_TRR_POR50</sub>	Time to re-ramp (when $V_{CC}$ drops to $V_{POR\_MIN} - 50$ mV)	See Figure 24	0.001			ms
V <sub>CC_GH</sub>	Level that $V_{CCP}$ can glitch down to, but not cause a functional disruption when $V_{CCX\_GW}$ = 1 $\mu s$	See Figure 25			1.2	V
V <sub>CC_GW</sub>	Glitch width that will not cause a functional disruption when $V_{CCX\_GH}$ = 0.5 x $V_{CCx}$	See Figure 25				μs
V <sub>PORF</sub>	Voltage trip point of POR on falling V <sub>CC</sub>		0.767		1.144	V
V <sub>PORR</sub>	Voltage trip point of POR on fising V <sub>CC</sub>		1.033		1.428	V

Table 1. Recommended Supply Sequencing and Ramp Rates <sup>(1)</sup>	Table 1.	Recommended	Supply	Sequencing	and Ramp	Rates <sup>(1)</sup>
--	----------	-------------	--------	------------	----------	----------------------

(1)  $T_A = -40^{\circ}C$  to 85°C (unless otherwise noted)



Glitches in the power supply can also affect the power-on reset performance of this device. The glitch width  $(V_{CC\_GW})$  and height  $(V_{CC\_GH})$  are dependent on each other. The bypass capacitance, source impedance, and device impedance are factors that affect power-on reset performance. Figure 25 and Table 1 provide more information on how to measure these specifications.

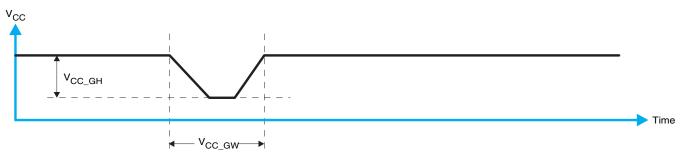
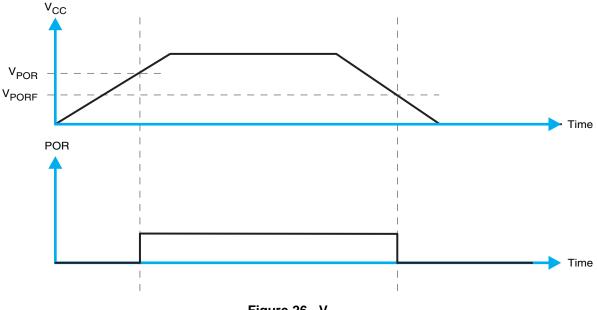


Figure 25. Glitch Width and Glitch Height

 $V_{POR}$  is critical to the power-on reset.  $V_{POR}$  is the voltage level at which the reset condition is released and all the registers and the I<sup>2</sup>C/SMBus state machine are initialized to their default states. The value of  $V_{POR}$  differs based on the V<sub>CC</sub> being lowered to or from 0. Figure 26 and Table 1 provide more details on this specification.







# 11 Layout

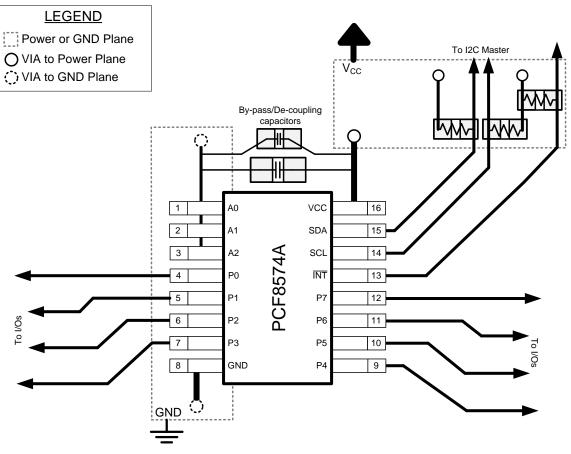
### 11.1 Layout Guidelines

For printed circuit board (PCB) layout of PCF8574A, common PCB layout practices should be followed but additional concerns related to high-speed data transfer such as matched impedances and differential pairs are not a concern for I2C signal speeds.

In all PCB layouts, it is a best practice to avoid right angles in signal traces, to fan out signal traces away from each other upon leaving the vicinity of an integrated circuit (IC), and to use thicker trace widths to carry higher amounts of current that commonly pass through power and ground traces. By-pass and de-coupling capacitors are commonly used to control the voltage on the  $V_{CC}$  pin, using a larger capacitor to provide additional power in the event of a short power supply glitch and a smaller capacitor to filter out high-frequency ripple. These capacitors should be placed as close to the PCF8574A device as possible. These best practices are shown in Figure 27.

For the layout example provided in Figure 27, it would be possible to fabricate a PCB with only 2 layers by using the top layer for signal routing and the bottom layer as a split plane for power ( $V_{CC}$ ) and ground (GND). However, a 4 layer board is preferable for boards with higher density signal routing. On a 4 layer PCB, it is common to route signals on the top and bottom layer, dedicate one internal layer to a ground plane, and dedicate the other internal layer to a power plane. In a board layout using planes or split planes for power and ground, vias are placed directly next to the surface mount component pad which needs to attach to VCC or GND and the via is connected electrically to the internal layer or the other side of the board. Vias are also used when a signal trace needs to be routed to the opposite side of the board, but this technique is not demonstrated in Figure 27.

### 11.2 Layout Example







# **12 Device and Documentation Support**

### 12.1 Trademarks

All trademarks are the property of their respective owners.

# 12.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

# 12.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms and definitions.

### 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser based versions of this data sheet, refer to the left hand navigation.



15-Apr-2017

# **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	-	Pins	-	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing	_	Qty	(2)	(6)	(3)		(4/5)	
PCF8574ADGVR	ACTIVE	TVSOP	DGV	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	PF574A	Samples
PCF8574ADGVRE4	ACTIVE	TVSOP	DGV	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	PF574A	Samples
PCF8574ADGVRG4	ACTIVE	TVSOP	DGV	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	PF574A	Samples
PCF8574ADW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	PCF8574A	Samples
PCF8574ADWE4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	PCF8574A	Samples
PCF8574ADWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	PCF8574A	Samples
PCF8574ADWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	PCF8574A	Samples
PCF8574AN	ACTIVE	PDIP	Ν	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-40 to 85	PCF8574AN	Samples
PCF8574ANE4	ACTIVE	PDIP	Ν	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-40 to 85	PCF8574AN	Samples
PCF8574APW	ACTIVE	TSSOP	PW	20	70	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	PF574A	Samples
PCF8574APWG4	ACTIVE	TSSOP	PW	20	70	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	PF574A	Samples
PCF8574APWR	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	PF574A	Samples
PCF8574APWRE4	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	PF574A	Samples
PCF8574APWRG4	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	PF574A	Samples
PCF8574ARGYR	ACTIVE	VQFN	RGY	20	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	PF574A	Samples
PCF8574ARGYRG4	ACTIVE	VQFN	RGY	20	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	PF574A	Samples

<sup>(1)</sup> The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.





15-Apr-2017

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect. NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design. PREVIEW: Device has been announced but is not in production. Samples may or may not be available. OBSOLETE: TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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# PACKAGE MATERIALS INFORMATION

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# TAPE AND REEL INFORMATION





# QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal <b>Device</b>	1	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
PCF8574ADGVR	TVSOP	DGV	20	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
PCF8574ADWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
PCF8574APWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
PCF8574ARGYR	VQFN	RGY	20	3000	330.0	12.4	3.8	4.8	1.6	8.0	12.0	Q1

TEXAS INSTRUMENTS

www.ti.com

# PACKAGE MATERIALS INFORMATION

16-Nov-2015



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
PCF8574ADGVR	TVSOP	DGV	20	2000	367.0	367.0	35.0
PCF8574ADWR	SOIC	DW	16	2000	367.0	367.0	38.0
PCF8574APWR	TSSOP	PW	20	2000	367.0	367.0	38.0
PCF8574ARGYR	VQFN	RGY	20	3000	367.0	367.0	35.0

# **MECHANICAL DATA**



- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- The Pin 1 identifiers are either a molded, marked, or metal feature.
- G. Package complies to JEDEC MO-241 variation BA.



# RGY (R-PVQFN-N20)

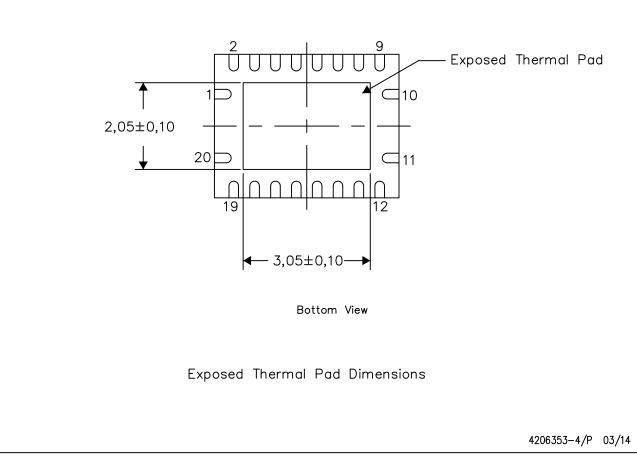
# PLASTIC QUAD FLATPACK NO-LEAD

### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



#### NOTE: All linear dimensions are in millimeters





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="http://www.ti.com">http://www.ti.com</a>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



# **MECHANICAL DATA**

PLASTIC SMALL-OUTLINE

MPDS006C - FEBRUARY 1996 - REVISED AUGUST 2000

# DGV (R-PDSO-G\*\*)

24 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
- D. Falls within JEDEC: 24/48 Pins MO-153

14/16/20/56 Pins – MO-194



PW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



NOTES:

A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.  $\beta$ . This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153



# LAND PATTERN DATA



NOTES: Α. All linear dimensions are in millimeters.

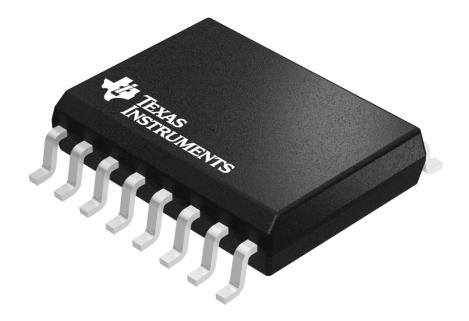
- B. This drawing is subject to change without notice.
  C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



# **GENERIC PACKAGE VIEW**

# SOIC - 2.65 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



4040000-2/H

# **DW0016A**



# **PACKAGE OUTLINE**

SOIC - 2.65 mm max height

SOIC



#### NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  This drawing is subject to change without notice.
  This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
- 5. Reference JEDEC registration MS-013.



# DW0016A

# **EXAMPLE BOARD LAYOUT**

# SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# DW0016A

# **EXAMPLE STENCIL DESIGN**

# SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



# N (R-PDIP-T\*\*)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- $\triangle$  The 20 pin end lead shoulder width is a vendor option, either half or full width.



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